

This paper presents a method to identify gravitational arcs or more generally elongated structures in a given image. The method is based on the computation of a local estimator of the elongation. The estimation of the local elongation proceed in two steps: first the local orientation of the structure is computed, then in the next step, a rotation is performed, and the marginal distributions are used to compute the elongation. This procedure allows the computation of the local elongation at each point in the image. Then, using a threshold on the elongation map the elongated structures are identified and re-constructed using connectivity criteria. Finally a catalog of elongated structures is produced, and the properties of each object are computed, allowing the selection of potential arc candidates. The final selection of the arc candidates is performed by visual inspection of multi-color images of a small number of objects. This method is a general tool that may be applied not only to gravitational arcs, but to all problems related to the mapping and measurement of elongated structures, in an image, or a volume.

Key words.

Automated detection of gravitational arcs

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Abstract.

1. Introduction

The new large scale surveys offers deep and well sampled views of large regions of the sky. These views contains such a large number of objects that automated method to find a specific type of objects is of great interest. In particular, the new release of the CFHTLS survey (see <http://www.cfht.hawaii.edu/Science/CFHLS/> for a description of the project) presents, a large set of 1 square degree images, with a corresponding size of about 20000×20000 pixels. Among a large number of interesting objects, this survey contains a number of gravitational arcs, typically one per image. Considering the huge number of pixels, finding theses arcs or arclets is a good task for an automated software. The identification of potential arcs in the image is mostly a search for elongated objects. Thus an automated method designed to find arcs should first produce a catalog of elongated objects and select possible arcs candidates among them. In the end the procedure should be concluded by a visual inspection of a small number of candidates. This method is a new approach, former methods relied on filtering, for instance, Lerzer, Scherzer & Schindler, (2004 & 2005), used anisotropic filtering, while Starck, Donoho & Candes (2003) used wavelet Filtering. Arc detections using catalogs from the SExtractor software (Bertin & Arnouts 1996), were also performed by Horesh *et al.* 2005.

2. The method

In general arcs or arclets appear in the image as very elongated structures, almost flat along the elongated direction and nearly as narrow as the PSF along the other. Other structures in the image may have similar elongations, but along the smaller dimension they are rarely as narrow as the PSF. Some spiral arms or a random coincidence of small and faint structure, may be confused

with arcs, but most structures are not as narrow an arclet can be. Thus by selecting elongated and narrow structures in the image, we should build a sample which contains a significant fraction of arcs. Once this sample is constructed the next step will be to characterize the arcs in the sample, with respects to the other contaminants, which can be real structures in the image, but also defects due to bright stars. The paper is organized as follows: in the first part, an estimator of the local elongation at small scale is introduced. The second part analyze the effect of the noise in the image on the estimation of the local elongation. And finally, some illustration of the practical implementation of the method will be given.

2.1. Reconstruction of the narrow elongated structures in the image

2.1.1. Estimating the local elongation at small scale

At each point in the image defined by its coordinates (x_0, y_0) we wish to estimate the local elongation at the scale of the PSF. The elongation is computed by analyzing the pixels in a window of size about a few times the effective size of the PSF around the point of interest. The first point in this analysis is to estimate the local orientation of the structure, by computing its second order moments. Then using the orientation defined by the moments, the local axis ratio is estimated using the 2 marginal distributions I_Y , and, I_X in the proper axis. To be more specific, the orientation is defined by the second orders moments:

$$\begin{aligned} a &= \int I(x_0 + x_1, y_0 + y_1) x_1^2 dx_1 dy_1 \\ b &= \int I(x_0 + x_1, y_0 + y_1) y_1^2 dx_1 dy_1 \\ c &= \int I(x_0 + x_1, y_0 + y_1) x_1 y_1 dx_1 dy_1 \end{aligned}$$

The coordinates (x_1, y_1) , are local coordinates with origin at the image coordinates (x_0, y_0) . The integration are performed in the interval $-M < x_1 < M$, and $-M < y_1 < M$. The direction of the main axis is then defined by the angle:

$$\tan(\theta) = -\frac{c}{-1/2 b + 1/2 a - 1/2 \sqrt{b^2 - 2ab + a^2 + 4c^2}} \quad (1)$$

We perform the rotation with angle θ and center (x_0, y_0) , in order to move from the original local coordinates (x_1, y_1) , to the proper coordinates (x, y) . In proper coordinates the direction of maximum elongation is along the x axis. We then define The marginal distribution:

$$\begin{aligned} I_X(x) &= \int I(x_0 + x, y_0 + y) dy \\ I_Y(y) &= \int I(x_0 + x, y_0 + y) dx \end{aligned}$$

At each position in the image (x_0, y_0) , we define the following measurement of the local elongation:

$$Q(x_0, y_0) = \frac{1}{2M} \frac{I_Y(0)}{\sup [I_X(x)]_{-M < x < M}} \quad (2)$$

each direction, then locally, $I(x_0 + x, y_0 + y) = f(x) g(y)$ and we infer that:

$$Q(x_0, y_0) = \frac{1}{2M} \frac{\int f(x) dx}{\sup [f(x)]_{[-M < x < M]}} g(0)$$

In this calculation it was assumed that the profile along the small axis $g(y)$ is normalized, thus that $\int g(y) dy = 1$.

2.1.2. Properties of the estimator

The first case of interest is an arclet with flat profile along the tangential direction. Then, I_X is constant, and we have simply:

$$Q(x, y) = g(0)$$

Assuming that the profile $g(y)$ may be written as a generic function of the width of the profile a , $g(y) = \frac{1}{a} G\left(\frac{y}{a}\right)$ with $G(u)$ symmetrical in u and thus maximum at $u = 0$, we infer immediately that the estimator $Q(x, y)$ will be maximum at the center of the arc with a value $Q(x, y) = \frac{1}{a} G(0)$, which means clearly that $Q(x, y)$ will reach its maximum value at the center of the narrowest arcs. We may turn now to the general case, when the distribution I_X isn't flat. It is easy to find an upper bound for the integral on $f(x)$ in $Q(x, y)$ by using the upper bound on I_X , since $\sup I_X = \sup [f(x)]$, we infer that:

$$Q(x, y) \leq g(0)$$

Thus this estimator will be always maximum on flat and narrow elongated structures. Any variation along the tangential direction may be considered as the consequence of a finite scale length along this direction. In particular if the scale length of the variation is smaller than M , the estimator $Q(x, y)$ will give directly an estimation of the axis ratio. Assuming:

$$f(x) = B F\left(\frac{x}{b}\right)$$

And $b < M$, then

$$Q(x, y) = k b g(0) = \tilde{k} \frac{b}{a} G(0)$$

When b is larger than M the estimator $Q(x, y)$ is no longer the axis ratio. Actually the value of the main axis b saturate at the value of the box size M . The limiting value M for b is reached when the distribution becomes flat or equivalently when the effective scale-length becomes infinite.

2.1.3. Effect of the noise on the estimator

We may now evaluate the fluctuation of the estimator $Q(x, y)$ due to the noise in the image. The noise on the estimation of the local axis ratio may be decomposed in 2 parts. First, given an orientation of the local axis, there is some amount of noise due to the intrinsic noise on the marginal distribution. This part will be computed first. But there is also another source of noise (a priori un-correlated), which is due to the noise on the orientation θ of the local structure.

Assuming a variance σ_Y for I_Y , and σ_X for $\sup[I_X]$, the variance on Q may be expressed as:

$$\sigma_Q = \frac{I_Y^2}{I_X^2} \left(\frac{\sigma_Y}{I_Y^2} + \frac{\sigma_X}{I_X^2} \right)$$

The variance σ_Y of the marginal distribution $I_Y(y)$ scales like $\frac{1}{2M+1}$ with respect to the variance N^2 on the total flux in the box. The signal will scale like the integral on the profile marginal distribution $g(y)$ in a bin of width 1 pixel normalized by the total integral on $g(y)$. Since the arcs have about the width of PSF, and that the PSF may be modeled by a gaussian of width 4 pixels, we find that $I_Y(x)$ at the maximum of the arc will be about 1/4 of the total signal S . Then:

$$\frac{\sigma_Y}{I_Y^2} \simeq \frac{16}{2M+1} \frac{N^2}{S^2}$$

We turn now to the estimation of σ_X . Considering that the distribution probability of the noise has a partition function $\Phi(u)$, and a probability distribution $\phi(u)$, the probability distribution of the maximum of the distribution will be:

$$P_M(u) = (2M+1) \phi(u) \Phi(u)^{2M}$$

Assuming a gaussian probability distribution for the noise, we find that:

$$P_M(u) = K \exp(-u^2/\sigma^2) (1 + \operatorname{erf}(u/\sigma))$$

This distribution may be approximately modeled by a gaussian distribution with an offset u_0 : $P_X(u) = A \exp(-(u - u_0)^2/\tilde{\sigma})$. for $M \simeq 1.5$ seeing $\simeq 7$ pixels, we find that $\tilde{\sigma} \simeq 1/4 \sigma$. And finally we infer the signal to noise ratio the variance σ_X :

$$\frac{\sigma_X}{I_X^2} \simeq \frac{(2M+1)N^2}{4S^2}$$

And eventually, taking $M = 7$, for a well sample PSF, the signal to noise ratio for the estimator Q reads:

$$\frac{Q}{N_Q} = \frac{Q}{\sqrt{\sigma_Q}} \simeq 0.45 \left(\frac{S}{N} \right)$$

Which means that even for low signal to noise, $\frac{S}{N} \simeq 10$, the noise will be only 20 % of the signal. This is small compared to the usual dynamics on Q itself, which for our choice of parameter varies from about 1 to 3.

2.1.4. Noise on the estimation of the local orientation

An important problem is to estimate the error due to the noise image that we make in the estimation of θ . Most of the noise on the arclets is due to the fluctuation of the background, thus it will be assumed the amplitude of the noise is nearly constant. Lets call σ the variance of the pixels due to the background noise, the relevant noise on the moments is then:

$$\langle a^2 \rangle \simeq \sum_{i,j} \langle I_{i,j}^2 \rangle x^4 \simeq \sigma \int x^4 dx dy = \sigma 2/5 M^5$$

Similarly:

$$\langle b^2 \rangle \simeq \sigma 2/5 M^5$$

And:

$$\langle c^2 \rangle = \sigma \frac{4}{9} M^6$$

In order to obtain the variance on θ it is necessary to differentiate equation (1) with respect to (a, b, c) , and to add the respective variances. The final result may be expressed using the two proper second order momentum (α , and β) of the system. Since:

$$a = \sin(\theta)^2 (\beta - \alpha) + \alpha$$

$$b = \sin(\theta)^2 (\alpha - \beta) + \beta$$

$$c = \frac{\sin(2\theta)}{2} (\alpha - \beta)$$

$$\langle \theta^2 \rangle \simeq \frac{\cos(2\theta)^2}{(\alpha - \beta)^2} \frac{2 M^6}{5}$$

A useful quantity is the average variance.

$$\langle \bar{\theta}^2 \rangle \simeq 1/5 \frac{M^6 \sigma}{(\alpha - \beta)^2}$$

Considering that the total noise in a window of size M is:

$$N^2 = \sigma (2 M + 1)^2$$

And that the proper second order momentum may be rewritten, as a function of the proper size L_0 , L_1 , and of the total flux in the window, S :

$$\alpha = L_0^2 S$$

$$\beta = L_1^2 S$$

It is possible to estimate the variance on θ :

$$\langle \bar{\theta}^2 \rangle \simeq \frac{1}{20} \frac{N^2 M^4}{S^2 (L_0^2 - L_1^2)^2}$$

For a flat distribution like an arclet the size L_0 along the main axis is close to the size of the window M , while the other dimension is small and may be neglected. In this case the former expression reduces to:

$$\langle \bar{\theta}^2 \rangle \simeq 1/20 \frac{N^2}{S^2}$$

Which means that the error on θ depends only on the signal to noise. For small signal to noise, typically $\frac{S}{N} \simeq 10$ the error on θ is only of about:

$$N(\theta) = \sqrt{\langle \theta^2 \rangle} \simeq \sqrt{1/200} \text{ radians} \simeq 1^\circ$$

The error on θ has an effect on the estimation of the local elongation. The arclet will be represented by a quadratic polynomial in proper coordinates:

$$I(x, y) = F(a_0 x^2 + a_1 y^2)$$

Assuming that the arclet is mis-aligned by an angle $d\theta$ with its proper axis, the intensity of the arclet now reads:

$$I = F \left(\left[a_0 + (a_1 - a_0)d\theta^2 \right] x^2 + \left[a_0 + (a_0 - a_1)d\theta^2 \right] y^2 + 2(a_0 - a_1)d\theta xy \right)$$

In particular we are interested with the effect of this rotation on the scale of the distribution along its small axis. The distribution along a particular axis may be estimated by using the reduced one dimensional marginal distribution along this axis. Thus the effect of the rotation may be estimated by calculating the effect on the marginal distribution along the y axis:

$$I_Y = \int I(x, y) dx$$

Which may be re-written by changing the integration variable:

$$I_Y = \int F(\alpha u^2 + \beta y^2) du$$

With β :

$$\beta = a_1 \left(1 + (1 - a_1/a_0) d\theta^2 \right)$$

By introducing the scale length $L_0 = 1/\sqrt{a_0}$, and $L_1 = 1/\sqrt{a_1}$, and the new scale length of the marginal distribution, $\bar{L}_1 = 1/\sqrt{\beta}$, we obtain:

$$\bar{L}_1 = L_1 \left(1 + \frac{1}{2} \left(-1 + \frac{L_0^2}{L_1^2} \right) d\theta^2 \right)$$

As estimated in the former section, $d\theta^2 \simeq \frac{1}{200}$, and in our choice of parameters, $\frac{L_0}{L_1} \simeq 3$, we find that the relative difference between $\bar{L}_1$ and L_1 is only about 2 %. The effect of the rotation on the main axis smaller again, and thus the error on θ has a negligible effect on the estimation of the axis ratio.

2.2. Effect of local curvature

In this paper it was assumed that arclets or elongated structures may be de-composed in small rectilinear bits at the scale $2M$, which is basically a few times the size of the PSF. This is an excellent approximation for larger arcs, and the estimator $Q(x, y)$ is designed for this specific task. But it is interesting to study the behavior of the estimator for smaller arcs. As usual we assume that without curvature at local scale the profile can be de-composed along each direction: $I(x_0 + x, y_0 + y) = f(x) g(y)$. Assuming that structure is curved locally and may be approximated by a circle of radius R and that the tangential direction is along the x axis, the curvature introduce a small shift δy of the profile along the y direction. To the lowest order this shift is:

$$\delta y = \frac{x^2}{2R}$$

The shift δy has a negligible effect on I_X , thus the effect on $Q(x, y)$ will be related to the variation due to δY on I_Y only. With curvature, I_Y may be re-written:

$$I_Y(y) = \int f(x) g(y + \delta y) dx \simeq g(y) \int f(x) dx + \frac{dg}{dy} \int f(x) \frac{x^2}{2R} dx + \frac{d^2g}{d^2y} \int f(x) \frac{x^4}{4R^2} dx$$

Assuming that the profile along the y direction, $g(y)$ is symmetrical and that the derivative is continuous, we have $\frac{dg}{dy} = 0$. For an arclet, the profile along the x direction $f(x)$ may be approximated by a constant f_0 in the relevant interval. Then $I_Y(0)$ reads:

$$I_Y = 2 M g(0) \left(1 + \frac{M^4}{40R^2} \left[\frac{1}{g} \frac{d^2g}{dy^2} \right]_{y=0} \right)$$

We have now to evaluate the second derivative of the functional g near $y = 0$. Expanding g to order 2 in y , we have:

$$g(y) \simeq A \left(1 + \frac{y^2}{a^2} \right)$$

and subsequently:

$$I_Y \simeq 2 M g(0) \left(1 + \frac{1}{20} \left(\frac{M}{R} \right)^2 \left(\frac{M}{a} \right)^2 \right)$$

Numerically, the perturbation introduced by curvature may be evaluated as follows: M is about 1.5 times the seeing, S , and since $a = 2 \sqrt{\log(2)} S$, we have, $M \simeq 2.5S$. And finally we have:

$$\Delta_C \simeq 1.95 \left(\frac{S}{R} \right)^2$$

Basically, this means that the error is still acceptable (20 %, about the noise level for faint objects), when, R , is about 3 times the seeing.

3. Practical implementation.

3.1. Filtering

Finding arcs is equivalent to look for structures that have nearly the size of the PSF along one dimension. There is no scale length smaller than the PSF in the image, except artifacts due to the noise. Thus any filter that damps the lower frequencies while damping somewhat the noise will improve the detectability of the arcs. Such filters are basically band-pass filter, centered at the PSF scale. An example of such filter is a Mexican-hat filter:

$$M(x, y) = \exp\left(-\frac{x^2+y^2}{b^2}\right) - 0.5 \exp\left(-\frac{x^2+y^2}{2b^2}\right) \quad (3)$$

The value of the constant b should be estimated so that the filter width match the size of the PSF. It is clear that this 2-dimensional filter, will improve the detectability of structures at about the size of the PSF. But the real point of interest is the effect of the filter on a one-dimensional structure like an arclet. To estimate the effect of the filter on the arc, we may take advantage of the symmetry of the filter by making a local rotation around the filter center such that the X-axis will coincide with the direction tangential to the arc. Assuming that the arc has a flat profile along the tangential direction, and a gaussian profile along the narrow direction: $I(x) = \exp(-x^2/a^2)$, we may calculate the scalar-product with the mexican-hat defined in Eq (1). The amplitude of this scalar-product will be proportional to the amplitude of the arc after filtering. The scalar-product reads:

$$P(\eta) = \pi \eta \sigma^2 \left(\frac{1}{\sqrt{1+\eta^2}} - \frac{1}{\sqrt{2+\eta^2}} \right)$$

Number of pixels	mean value	pix nb/radius	radius	remarks
103	2.19	3.8	26.8	Central arclet
59	1.93	1.0	56.4	
53	1.81	0.9	58.5	
46	2.15	0.9	50.2	
45	1.59	0.8	50.7	

Table 1. paramaters of the structures found in the $Q(x, y)$ image (Fig. 2).

Number of pixels	mean value	pix nb/radius	radius	remarks
81	2.13	1.90	42.7	
79	1.97	1.28	61.6	
65	1.88	1.16	55.8	
58	1.61	0.91	63.5	
45	1.91	3.14	14.3	

Table 2. paramaters of the structures found in the $Q(x, y)$ image.

The functional $P(\eta)$ peaks at $\eta \simeq 0.838$, and decrease quickly for larger values of η . Thus it is clear that for maximum efficiency, given a scale a for the PSF, the scale σ of the filter must be: $\sigma \simeq 1.19a$.

3.2. Using the estimator $Q(x, y)$ to find elongated structures.

As explained in the former sections, at each point in the image the direction θ of the local structure is computed using the second order moments, a rotation is performed in order to be aligned with the direction of the local structure and finally the estimator $Q(x, y)$ is computed using Eq. (2). To illustrate the method, an image representing the value of the estimator $Q(x, y)$ at each point of the image presented in Fig. (1) is presented in Fig. (2). Local elongation of about 3 are reached within the arclet at the center of the image, and no-where else in the image. Actually if larger images were taken, some objects other than arclets, may also presents large value of the local elongation. For instance, edge-on spirals. Then the problem is to separate the arclets from the rest of the sample. This can be done mostly by computing the properties of the local structures as detected in Fig. (2). The structures in the $Q(x, y)$ image may be reconstructed using the ink-blot technique. A structure is defined as a set of pixels larger than some value, and the pixel must be connected each other. This way all the structures in the $Q(x, y)$ image may be reconstructed, and their properties: number of pixels, length, curvature,...ect, may be measured. It is generally possible to separate most of the arclets form other structures using these parameters. For this particular task it may be also useful to measure some of the parameters of the structures in the original image, like for instance their color or brightness. Table (1) gives the 5 largest structures found in the image presented in Fig. (2). Note that the actual field that was used is much larger than in Fig. (2), the effective field was of 1000×1000 pixels for Table 1.

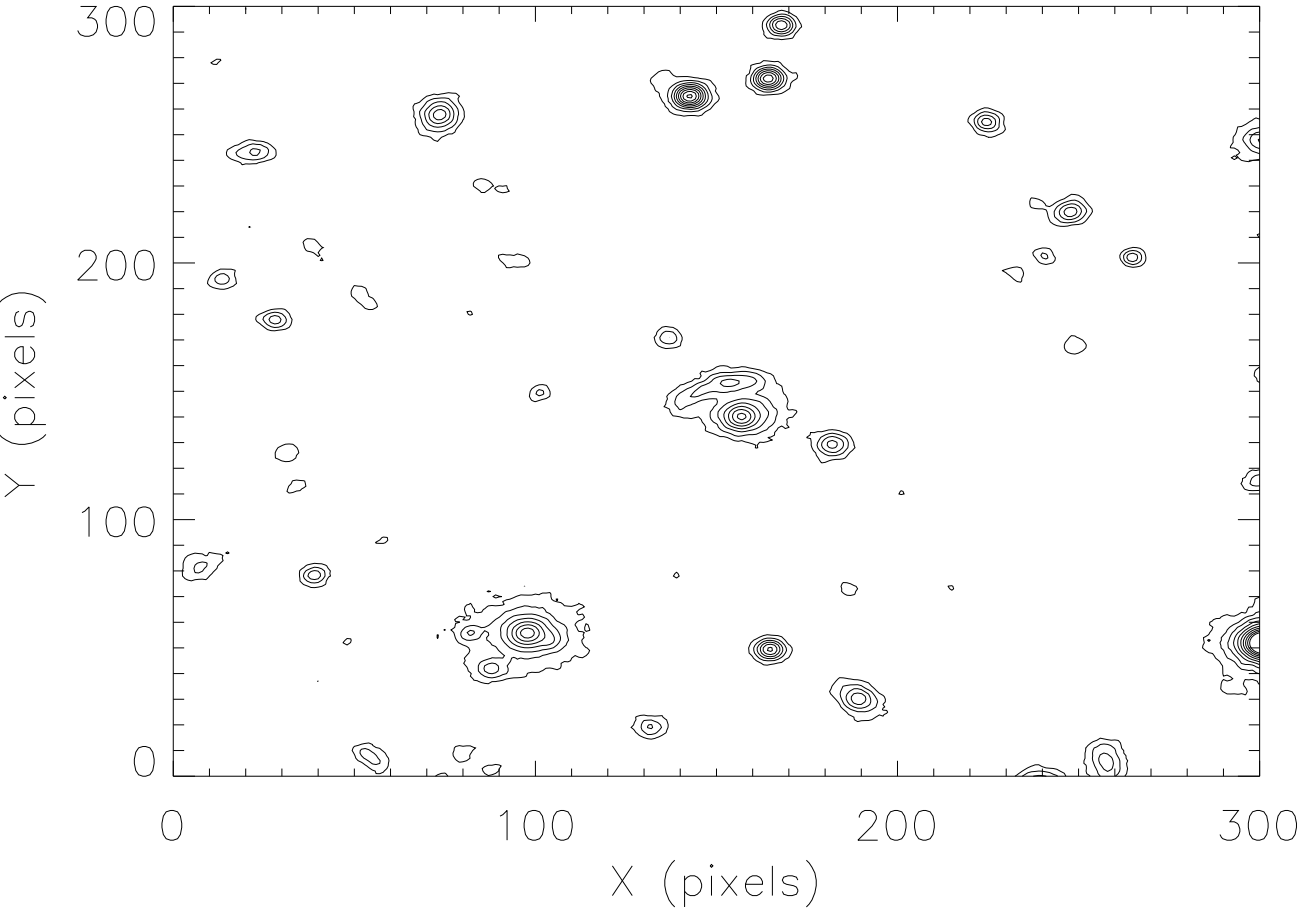


Fig. 1. Contour plot of a CFHT image. In this figure an arclet is visible at the center of the frame, near a bright source. This image will be used to illustrate the computation of the local estimator $Q(x,y)$ - (see Fig. 2).

3.3. Computing time

Considering the size of the image, the computation of the estimator $Q(x,y)$ as to be fast. The filtering and the computation of the second order moments can be greatly optimized using well known techniques, like the decomposability of the filters, or partial buffering of the calculations. However, it is more difficult to speed-up the calculation of the marginal distributions and of the estimator itself, since the orientation is not known in advance. But it is clear that the computation is not meaningful in all points of the image, first it is possible to introduce a threshold in the filtered image to perform the computation. A further gain of computing time may be operated by calculating the estimator only near uni-dimensional local maxima. Uni-dimensional local-maximas are maximas along a particular direction, like for instance the kind of maxima that will be found on a direction perpendicular to an arclet. Since a priori the orientation of the arclet is not known, the maximas will be searched both along the x and y axis. Each local maxima along

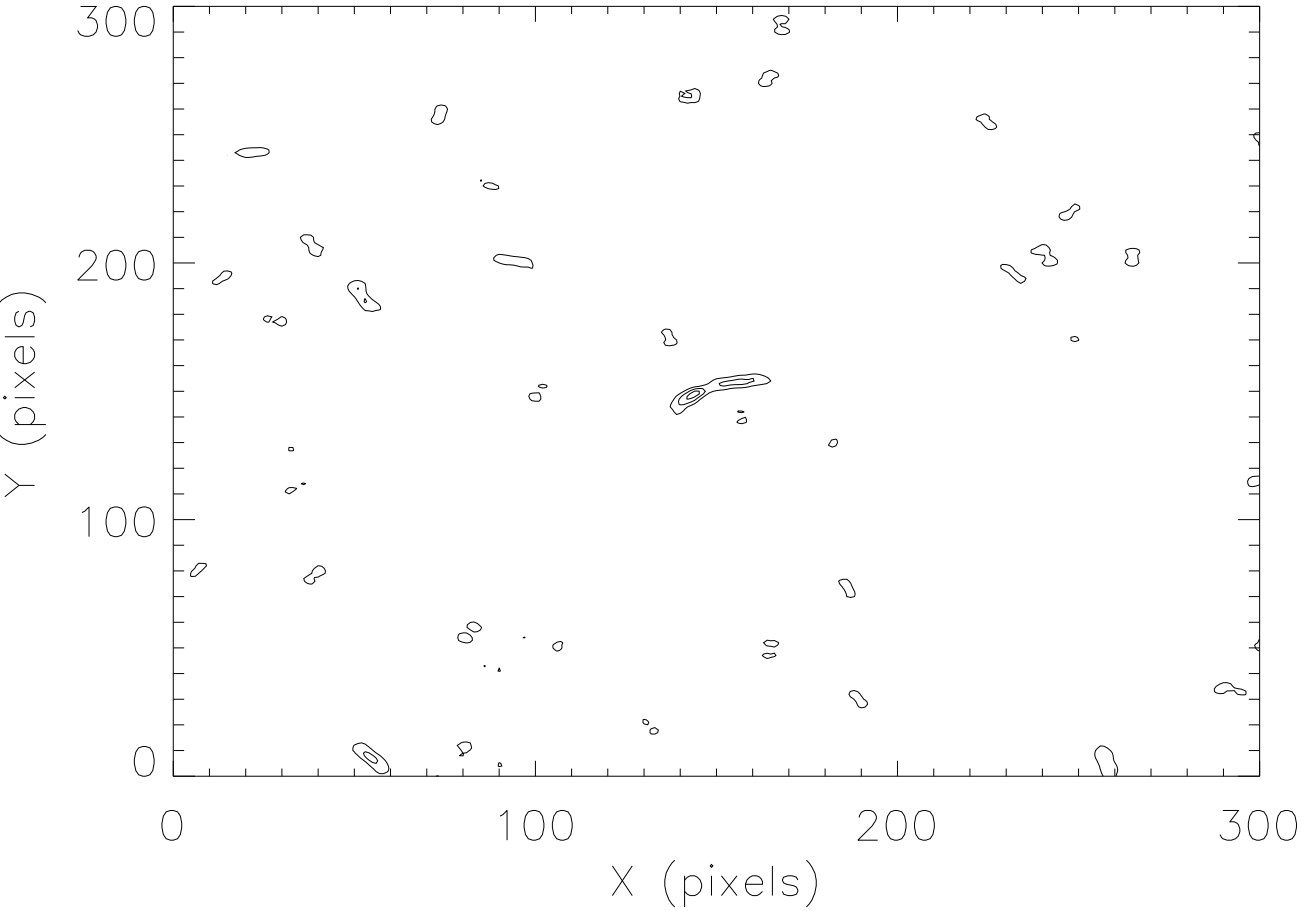


Fig. 2. The contour plots in this image represents the local values of the estimator $Q(x,y)$ at each point of the image presented in Fig. 1. The contours were plotted using a linear scale, and the highest contours (which are located in the arclet) are about 3 times higher than the lowest contours.

the x or y axis will be defined as a point where the estimator $Q(x,y)$ has to be calculated. This procedure speeds-up the computation of $Q(x,y)$ by about a factor of 10 in a typical CFHTLS image.

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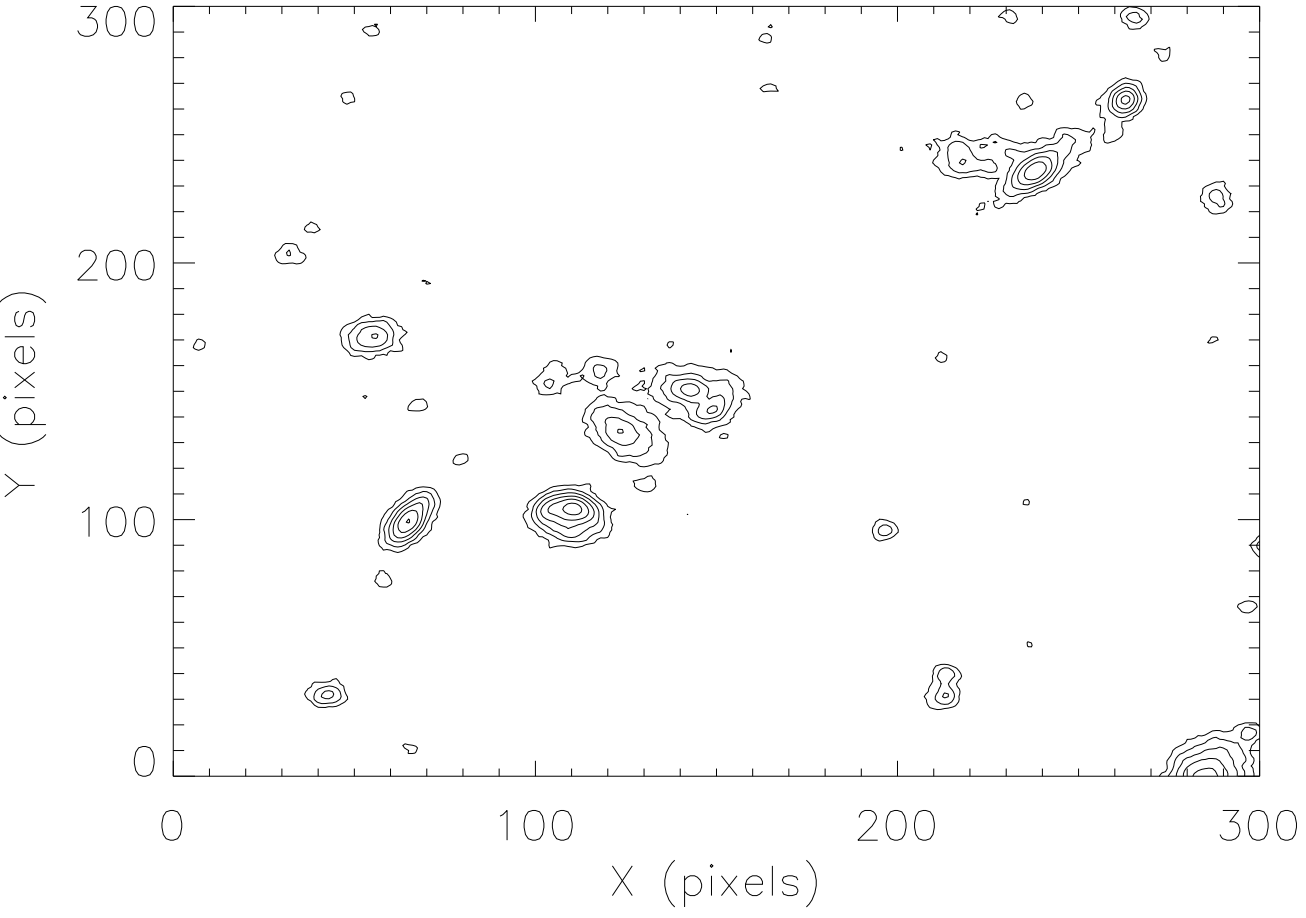


Fig. 3. A small and faint arclet is located near the center of the image. Note that this small arc is very close to the deflector, and that there is some blending of the light with the lens.

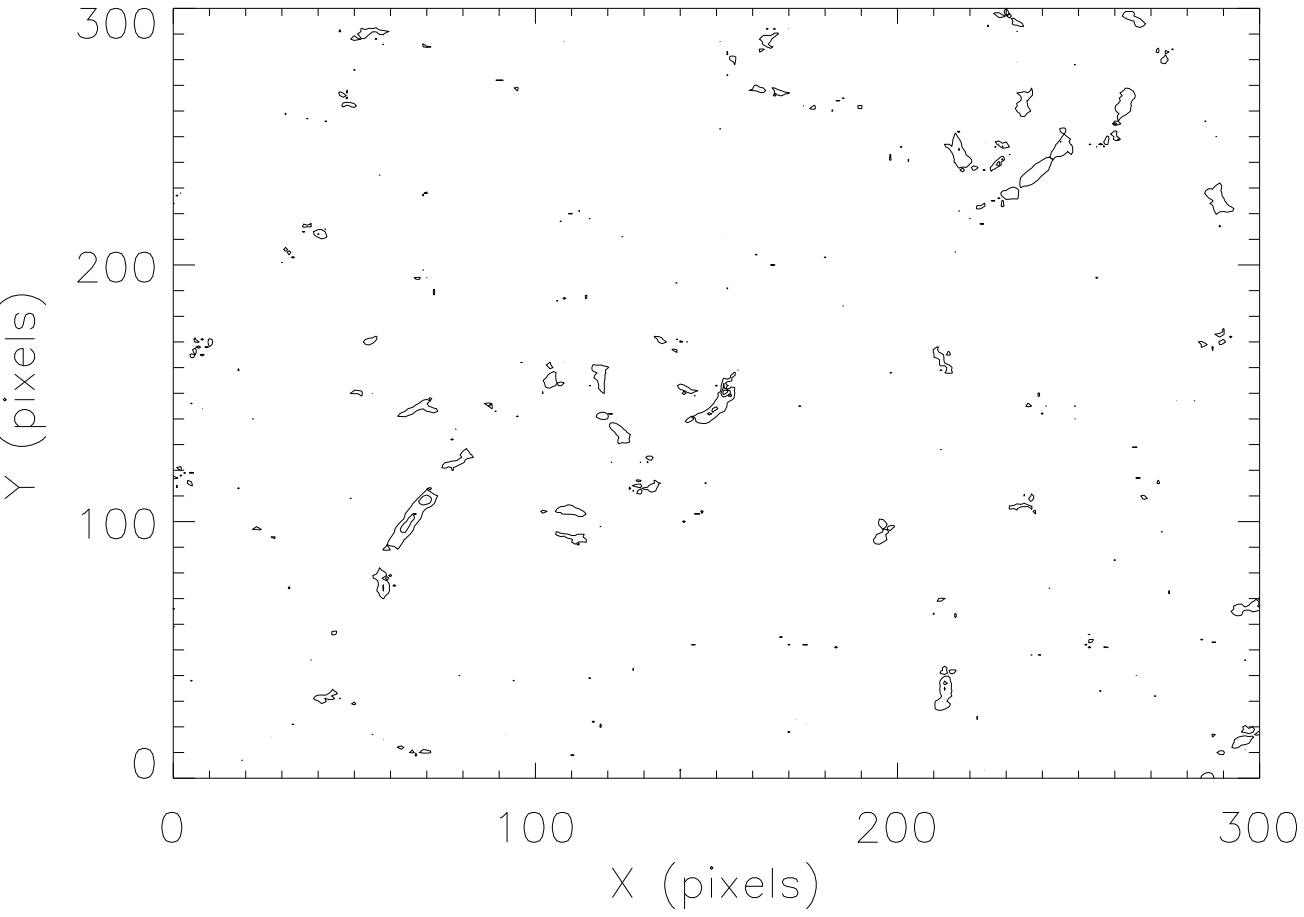


Fig. 4. When estimating the local elongation $Q(x,y)$ the arclet appears now clearly, and stands out in the image.